

Notice of References Cited

Application/Control No.

10/593,470

Applicant(s)/Patent Under
Reexamination
MIYAMOTO ET AL.

Examiner

JOHN K. KIM

Art Unit

2834

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0048249	12-2001	Tsuboi et al.	310/12
*	B	US-6,441,515	08-2002	Shimura, Yoshiki	310/12
*	C	US-5,801,462	09-1998	Yagoto et al.	310/12
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	01037334.pdf: Jong et al (2002 IEEE publication, "Smart Silicon Sensor – Example of Hall Effect Sensors")
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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